



#### Miniature MEMS Interface Circuits Using Nanoparticle Conductors and Embedded Components

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### **MEMS Sensor systems**





### **MEMS System Integration**

#### A. MIniature size with flexible form factor

- i. Smallest component sizes
- ii. Fine-feature interconnect
- iii. 3D construction
- **B.** Low-cost assembly
  - i. Minimize capital/labor costs
  - ii. Low materials costs
  - iii. Minimal waste stream
- C. Quick-turn with small/large batch compatibility
  - i. Packaged components
  - ii. CAD/CAM processes

## Conventional PCB Technology

- Highly-Developed, proven technology
- Many competent vendors

But...

#### There's room for improvement

- Feature sizes < 50 microns are challenging
- Basically a 2D technology
- Lots of capital equipment, floor space, industrial waste











## Embedded 3D Fabrication



- Many different/similar techniques
  - GE (1994 patent), Freescale, Verdant Electronics, Imbera, Ga Tech, Fraunhofer, ....etc.
- Well known benefits
  - High component density
  - Eliminate solder connections
  - Simplify supply chain
- Potomac's contribution: Simplicity

## Approach





- **1.** Fabricate fine feature interconnects on thin substrates
  - Nanoparticale silver conductors
  - Laser direct-write processes
- 2. Attach packaged components
- 3. Encapsulate components
- 4. Stack modules

#### **Nano-Ag conductor fabrication**





**Finished circuit** 



## **Embedded Nanoparticle Conductors**



- Nanoparticle conductor advantages:
  - Eliminate photolithography
  - Conductor width limited only by laser focal spot size.
    - <10 micron trace/space demonstrated</li>
    - Controllable aspect ratio
  - Additive, green process





Silver aspect ratio compensates for higher resistivity



## Narrow traces reduce layer count





15 micron trace/space



100 micron trace/space



#### Examples: Polyimide substrate



**Battery-powered LED flasher** 



← \_\_\_\_\_ 35 mm \_\_\_\_\_

Strain gauge interface

Single Layer Circuits !

#### Examples: Alternative Substrates





Working circuits





Pads and 15 micron traces



—— Alumina——→





### **Stretchable Interconnects**



#### System example: NSF Wireless sensor platform mockup







## Size Reduction + Freedom of Form Factor



- Volume reduction through high density packaging and fine line interconnects.
- Laser based CAD/CAM process allow wide range of shapes

# Miniature systems based on additive processes





- Process temperatures < 200 C</li>
- Negligible waste stream

#### **Example: Amplifier module fabrication**



## Layout



**Schematic** 



10 mm

All CAD/CAM processes are driven by layout



## **Conductors and Coverlay**



Laser pattern and fill frontside and backside conductors



Apply, laser image and develop (aqueous) frontside coverlay



## **Dispense adhesive and populate**



Dispense epoxy using locations derived from layout



Pick and place components using locations derived from layout

Must have high accuracy and repeatability



- Vacuum/pressure encapsulation with thermal cure
  - Eliminate voids
  - Flat outer surfaces
- Encapsulant material requirements:
  - Compatible TCE
  - Adhesion to coverlay and components
  - Suitable flow and curing properties

# Connection to and between modules





- Conductive vias for interconnection of modules
  - Laser drilled
  - Epoxy filled
  - Many other options

**Example: Amplifier module fabrication** 



#### **Encapsulation, Vertical Vias, Backside Components**





Encapsulated circuit with patterned backside coverlay

**Completed modules** 



## **Communication Module**



Wireless SoC with passives



Encapsulated module with exposed chip antenna and MEMS microphone

# FlexEl, LLC Advanced Thin Film Battery





ΡΟΤΟΜΛC

MESOSYSTEMS

- New RuOx chemistry gives >10 mA-hr/cm2
- < 0.3 mm thickness
- 10 x 10 mm<sup>2</sup> footprint

**Example: Wireless sensor mockup** 



## **Complete wireless sensor**





## **Electrical Test**

Several intermediate testing opportunities during module production

- After interconnect fab
- After component attach
- After encapsulation
- After stacking



10X Amp Gain (after component attach)



Amplified microphone output (after module completion)

## Capital Equipment Required



Integrated Laser/PnP/Dispense





Paste fill & clean station



**Encapsulation mold** 



# Capital Equipment <u>NOT</u> required



**Resist exposure system** 



**Etching/Plating tanks** 



Lamination Press



## **Scaling to higher volume**





UV laser system



Paste fill & clean station



**Encapsulation mold** 



Epoxy Dispenser



Pick and Place



#### **Module cost estimate**



- Component costs dominate
- Materials costs negligible

# **Thermal cycling tests**





#### **40 element Daisy Chains**



## It's a work in progress, but....

<b>Development Goal</b>	No	Yes
High Miniaturization		~
Flexible, 3D form factors		$\checkmark$
Low-cost assembly		$\checkmark$
Green fabrication processes		$\checkmark$
Small/large batch manufacturing		$\checkmark$
Minimal capital equipment		$\checkmark$



## **Collaboration and evaluation**

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